

SCES409B-AUGUST 2002-REVISED OCTOBER 2004

FEATURES	DGG, DGV		
<ul> <li>Member of the Texas Instruments Widebus™ Family</li> </ul>	•	(OR DE P)	
Ideal for Use in PC133 Register DIMM			]GND
<ul> <li>Typical Output Skew &lt;250 ps</li> </ul>			]NC
<ul> <li>V<sub>CC</sub> = 3.3 V ± 0.3 V Normal Range</li> </ul>	Y1 [] 3		]A1
• V <sub>CC</sub> = 2.7 V to 3.6 V Extended Range	GND [] 4 Y2 [] 5		]GND ]A2
• $V_{CC} = 2.5 V \pm 0.2 V$	Y3 6	1	]A2 ]A3
<ul> <li>Rail-to-Rail Output Swing for Increased Noise</li> </ul>		r	]V <sub>CC</sub>
Margin	Υ <u>Υ</u> ΥΥ		]A4
<ul> <li>Balanced Output Drivers ±18 mA</li> </ul>	Y5 [] S	t	]A5
-	Y6 🛛 1		]A6
Low Switching Noise	GND 🛛 1		GND
Latch-Up Performance Exceeds 100 mA Per	Y7 🚺 1	12 45	A7
JESD 78, Class II	Y8 🚺 1	13 44	] A8
ESD Protection Exceeds JESD 22	Y9 🛽 1		A9
– 2000-V Human-Body Model (A114-A)	Y10 🛛 1		A10
– 200-V Machine Model (A115-A)	Y11 🛛 1		A11
<ul> <li>– 1000-V Charged-Device Model (C101)</li> </ul>	Y12 1		A12
		r	]GND
DESCRIPTION/ORDERING INFORMATION			]A13
This 18-bit universal bus driver is designed for	Y14 2 Y15 2	r i i i i i i i i i i i i i i i i i i i	]A14 ]A15
2.3-V to 3.6-V V <sub>CC</sub> operation.		r	]V <sub>CC</sub>
Data flow from A to Y is controlled by the	Y16 2		]A16
output-enable $(\overline{OE})$ input. The device operates in the	Y17 1 2	r	]A17
transparent mode when the latch-enable (LE) input is			]GND
low. When $\overline{\text{LE}}$ is high, the A data is latched if the	Y18 2		A18
clock (CLK) input is held at a high or low logic level. If LE is high, the A data is stored in the latch/flip-flop on		27 30	]CLK
the low-to-high transition of CLK. When $\overline{OE}$ is high.		28 29	]GND

NC - No internal connection

The ALVCF162834 has series damping resistors in the device output structure that reduce switching noise in 128-MB and 256-MB SDRAM modules. Designed with a drive capability of ±18 mA, this device is a midway drive between the ALVC162834 (±12 mA) and ALVC16834 (±24 mA).

The SN74ALVCF162834 is a faster version of the SN74ALVC162834. It is suitable for PC133 applications, particularly for SDRAM modules clocked at 133 MHz.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

T <sub>A</sub>	PA	TOP-SIDE MARKING							
	SSOP - DL	Tube	SN74ALVCF162834DL	ALVCF162834					
-40°C to 85°C	550P - DL	Tape and reel	SN74ALVCF162834DLR	- ALVUF 102034					
-40 C 10 85 C	TSSOP - DGG	Tape and reel	SN74ALVCF162834GR	ALVCF162834					
	TVSOP - DGV	Tape and reel	SN74ALVCF162834VR	VF162834					

#### **ORDERING INFORMATION**

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at (1)www.ti.com/sc/package.



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the low-to-high transition of CLK. When  $\overline{OE}$  is high,

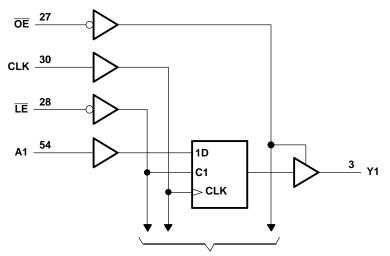
the outputs are in the high-impedance state.

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	INPUTS							
ŌĒ	LE	CLK	Α	Y				
Н	Х	Х	Х	Z				
L	L	х	L	L				
L	L	х	Н	н				
L	Н	$\uparrow$	L	L				
L	Н	$\uparrow$	Н	н				
L	Н	L or H	Х	Y <sub>0</sub> <sup>(1)</sup>				

#### **FUNCTION TABLE**

(1) Output level before the indicated steady-state conditions were established



### LOGIC DIAGRAM (POSITIVE LOGIC)

To 17 Other Channels



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### **ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
VI	Input voltage range <sup>(2)</sup>	-0.5	4.6	V	
Vo	Output voltage range <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through each V <sub>CC</sub> or GN	ID		±100	mA
		DGG package		64	
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	DGV package		48	°C/W
		DL package		56	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 4.6 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

### **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		2.3	3.6	V	
V	Llich lovel input voltoge	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7		V	
V <sub>IH</sub>	High-level input voltage	$V_{CC}$ = 2.7 V to 3.6 V	2		v	
V		$V_{CC}$ = 2.3 V to 2.7 V		0.7	V	
V <sub>IL</sub>	Low-level input voltage	$V_{CC}$ = 2.7 V to 3.6 V		0.8	v	
VI	Input voltage		0	V <sub>CC</sub>	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V – 2.2 V		-6	mA	
		V <sub>CC</sub> = 2.3 V		-8		
l <sub>он</sub>	High-level output current	$V_{CC} = 2.7 V$		-6		
	nigh-level output current	$v_{\rm CC} = 2.7 v$		-12		
		$V_{CC} = 3 V$		-8		
		$v_{\rm CC} = 3 v$		-18		
		V <sub>CC</sub> = 2.3 V		6		
		$v_{CC} = 2.3 v$		8		
		V 07V		6		
I <sub>OL</sub>	Low-level output current	$V_{CC} = 2.7 V$		12	mA	
				8		
		$V_{CC} = 3 V$		18		
$\Delta t/\Delta v$	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

Р	ARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
		I <sub>OH</sub> = -0.1 mA	2.3 V to 3.6 V	V <sub>CC</sub> - 0.2			
		I <sub>OH</sub> = -6 mA	2.3 V	1.9			
		I <sub>OH</sub> = -8 mA	2.3 V	1.7			
V <sub>OH</sub>		I <sub>OH</sub> = -6 mA	A 2.7 V				V
		I <sub>OH</sub> = -12 mA	2.7 V	2			
		I <sub>OH</sub> = -8 mA	- 3 V	2.4			
		I <sub>OH</sub> = -18 mA	3 V	2			
		I <sub>OL</sub> = 0.1 mA	2.3 V to 3.6 V			0.2	
		I <sub>OL</sub> = 6 mA	- 2.3 V			0.4	
		I <sub>OL</sub> = 8 mA	2.3 V			0.55	
V <sub>OL</sub>		I <sub>OL</sub> = 6 mA	2.7 V			0.4	V
		I <sub>OL</sub> = 12 mA	2.7 V			0.6	
		I <sub>OL</sub> = 8 mA	2.14			0.55	
		I <sub>OL</sub> = 18 mA	3 V			0.8	
V <sub>IK</sub>		V <sub>CC</sub> = 2.3 V, I <sub>I</sub> = -18 mA	3.6 V			-1.2	V
V <sub>hys</sub>		V <sub>CC</sub> = 3.6 V	3.6 V		100		mV
I <sub>I</sub>		$V_{I} = V_{CC} \text{ or } GND$	3.6 V			±5	μΑ
I <sub>OZ</sub>		$V_{O} = V_{CC}$ or GND	3.6 V			±10	μΑ
I <sub>CC</sub>		$V_{I} = V_{CC} \text{ or GND}, I_{O} = 0$	3.6 V		0.1	40	μΑ
$\Delta I_{CC}$		One input at $V_{CC}$ - 0.6 V, Other inputs at $V_{CC}$ or GND	3 V to 3.6 V			750	μA
Ci	Inputs	$V_{I} = 0 V$	3.3 V		3		pF
Co	Outputs	$V_0 = 0 V$	3.3 V		4		pF

(1) All typical values are at V\_{CC} = 3.3 V, T\_A = 25 ^{\circ}C.

### TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 and Figure 2)

				V <sub>CC</sub> = ± 0.2	V <sub>CC</sub> = 2.5 V ± 0.2 V		2.7 V	$V_{CC}$ = 3.3 V ± 0.3 V		UNIT	
				MIN	MAX	MIN	MAX	MIN	MAX		
f <sub>clock</sub>	Clock frequency				150		150		150	MHz	
t <sub>w</sub> Pulse duration		LE low		3.3		3.3		3.3		20	
		CLK high or low	3.3		3.3		3.3		ns		
		Data before CLK↑		1.8		1.5		1			
t <sub>su</sub>	Setup time	Data before LE↑	CLK high	1.9		1.6		1.5		ns	
	Data before LE	CLK low	1.3		1.1		1				
	Data after CLK↑		0.6		0.6		0.6				
t <sub>h</sub>	Hold time	Data after LE↑	CLK high or low	1.4		1.7		1.4		ns	



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### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO	$V_{CC}$ = 2.5 V $\pm$ 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPOT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			150		150		150		MHz
	А		1	4		4.6	1	3.5	
t <sub>pd</sub>	LE	Y	1.3	5.5		5.4	1.3	4.6	ns
	CLK		1.4	5.9		5.6	1.4	3.5	
t <sub>en</sub>	OE	Y	1.4	5.9		6	1.1	5	ns
t <sub>dis</sub>	OE	Y	1	4.7		4.6	1.3	4.2	ns
t <sub>sk(o)</sub>								500	ps

### SWITCHING CHARACTERISTICS

from 0°C to 65°C,  $C_L = 50 \text{ pF}$ 

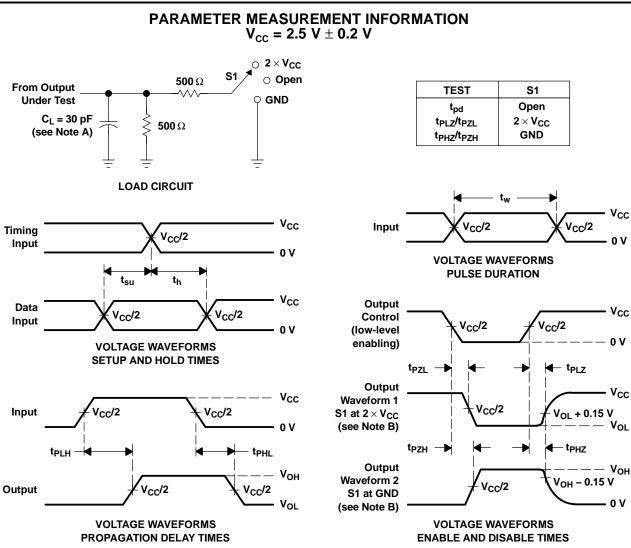
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 3. ± 0.15	UNIT	
	(14-01)	(001-01)	MIN	MAX	
t <sub>pd</sub>	CLK	Y	1.8	3.5	ns

### **OPERATING CHARACTERISTICS**

 $T_A = 25^{\circ}C$ 

		PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT
	C <sub>pd</sub> Power dissipation capacitance		Outputs enabled	C = 0 f = 10 MHz	28	33	۶E
			Outputs disabled	$C_{L} = 0, f = 10 \text{ MHz}$	16	21	pF

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TEXAS IRUMENTS

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NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

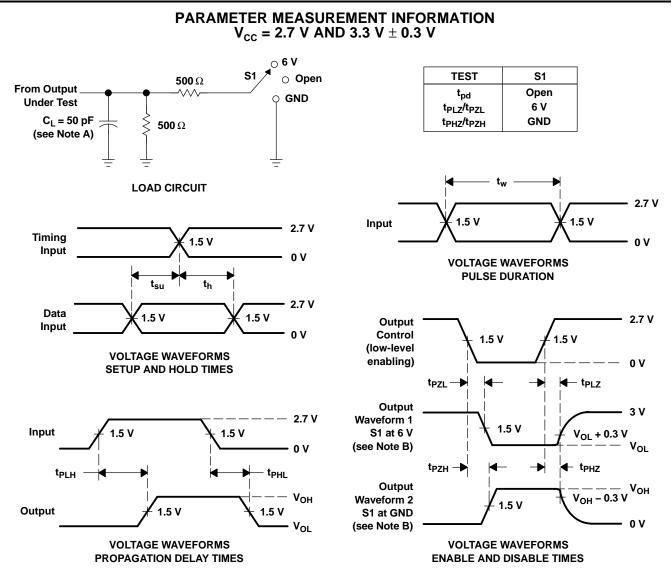
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

#### Figure 1. Load Circuit and Voltage Waveforms

#### IEXAS **TRUMENTS** www.ti.com

### SN74ALVCF162834 3.3-V CMOS 18-BIT UNIVERSAL BUS DRIVER WITH 3-STATE OUTPUTS

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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns. The outputs are measured one at a time, with one transition per measurement.
- D.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Figure 2. Load Circuit and Voltage Waveforms



10-Jun-2014

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVCF162834DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCF162834	Samples
SN74ALVCF162834GR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCF162834	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE OPTION ADDENDUM

10-Jun-2014

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## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

TEXAS INSTRUMENTS





#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal	

TAPE AND REEL INFORMATION

Device	•	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCF162834GR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVCF162834GR	TSSOP	DGG	56	2000	367.0	367.0	45.0

DL (R-PDSO-G56)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
  - This drawing is subject to change without notice. В.
  - Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15). C.
  - D. Falls within JEDEC MO-118

PowerPAD is a trademark of Texas Instruments.



# **PACKAGE OUTLINE**

# **DGG0056A**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not

- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-153.



# DGG0056A

# **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DGG0056A

# **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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